Search Notes



	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/706,115	LOOK, KEVIN T.
	Examiner	Art Unit
_	Steven J. Fulk	2891

SEARCHED						
Class	Subclass	Date	Examiner			
257	390	7/26/2005 (*pd-tag: 11/16/05)	SJF (JJF)			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
PG Pub Docs	Claim text	11/16/05	224		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
365/72,96,103- 104,148,174,177,189.07,189.09 (text search only - see search history printout)	7/26/2005 (bpdofed il/16/05)	SJF		
257/50,202,208- 209,213,225,260,273,370,390- 391,402,412-413,377-378,529- 530,755,757,773,903-904,928,314 (text search only)	7/26/2005 (updoted 11/16/03)	SJF (OF)		
438/132,197,215,281,385,466-467 (text search only - see search history printout)	7/26/2005 (4pdated (4/16/05)	SJF ( <i>SJF</i> )		